



Advances in Security, Trust and Privacy in Internet of Things

Guest Editors:

Message from the Guest Editors

Dr. Weidong Fang

Science and Technology on
Micro-System Laboratory,
Shanghai Institute of Micro-
System and Information
Technology, Chinese Academy of
Sciences, Shanghai 201800,
China

Dr. Chunsheng Zhu

SUSTech Institute of Future
Networks, Southern University of
Science and Technology,
Shenzhen 518055, China

Prof. Dr. Andrew W. H. Ip

Department of Mechanical
Engineering, University of
Saskatchewan, Saskatoon, SK
S7N 5A2, Canada

This Special Issue of Applied Sciences aims to explore recent advancements and emerging trends in addressing the complex challenges associated with securing IoT devices, establishing trust relationships, and safeguarding user privacy in an increasingly interconnected world. By bringing together experts from academia, industry, and government, we seek to foster dialogue and collaboration towards enhancing the security, trustworthiness, and privacy of IoT deployments. By disseminating cutting-edge research and best practices, we hope to empower stakeholders to build more secure, trustworthy, and privacy-respecting IoT systems that enhance the quality of life for individuals and communities worldwide.

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Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo
Dipartimento di Fisica,
Politecnico di Milano, Piazza L.
da Vinci 32, 20133 Milano, Italy

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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Applied Sciences Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland

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